

**Notice of References Cited**

Application/Control No.

10/551,437

Applicant(s)/Patent Under  
Reexamination  
TOGAWA ET AL.

Examiner

Dwan A. Gerido, Ph.D.

Art Unit

1797

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-3,837,376	09-1974	Brown et al.	141/1
*	B	US-5,308,506	05-1994	McEwen et al.	210/745
*	C	US-2,833,281	05-1958	KRUG ALBERT E	604/406
*	D	US-5,624,554	04-1997	Faulkner et al.	210/232
*	E	US-5,213,765	05-1993	Kasai et al.	422/101
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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